NOTES:

1. SUBSTRATE MATERIAL: FUSED SILICA

- 2. CLEAR APERTURE AND COATING APERTURE ARE CENTERED ON SURFACE
- 3. COATING (APPLY ACROSS CLEAR APERTURE)
 S1: R(AVG) > 99.0% FROM 260-267nm AT 45° AOI
 DAMAGE THRESHOLD,
 PULSED: 2.5 J/cm²,20 ns, 20 Hz @ 266 nm
 CW: 500 kW/cm² @ 1064 nm

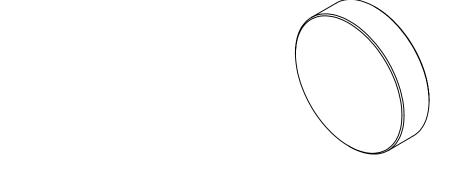
S2:NONE

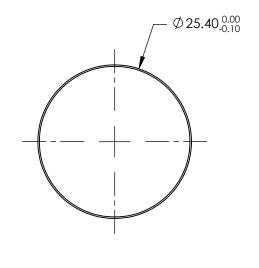


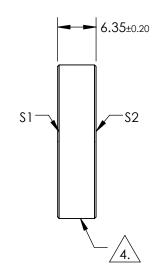
FINE GRIND SURFACE

- 5. SURFACE FLATNESS AND SURFACE QUALITY
 SPECIFICATIONS APPLY ACROSS CLEAR APERTURE
- 6. Rohs: Compliant









SPECIFICATIONS SUBJECT TO CHANGE WITHOUT NOTICE DIMENSIONS ARE FOR REFERENCE ONLY

REV. A	\$1	\$2			Edmund Optics®	,
SHAPE	PLANO	PLANO				
SURFACE FLATNESS	0.1 WAVE	N/A			Ø25.4mm, 266nm, Nd-YAG LASER LINE	
SURFACE QUALITY	10 - 5	N/A	THIRD ANGLE PROJECTION	TITLE	MIRROR (STANDARD)	
CLEAR APERTURE	Ø21.59	Ø21.59			` '	
BEVEL	PROTECTIVE AS NEEDED	PROTECTIVE AS NEEDED	ALL DIMS IN mm	DWG NO	34815 SHEE 1 OF	